



Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
20V	9.5mΩ @ V _{GS} = 4.5V	12.2 A
200	13mΩ @ V _{GS} = 2.5V	10.4 A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

- General Purpose Interfacing Switch
- Power Management Functions

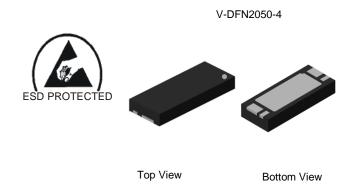
DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

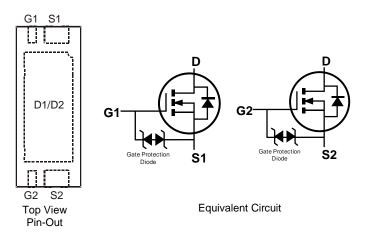
Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3) Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: V-DFN2050-4
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208@
- Weight: 0.01 grams (Approximate)





Ordering Information (Note 4)

Part Number	Case	Packaging
DMN2011UFX-7	V-DFN2050-4	3,000 / Tape & Reel

No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
See http://www.diodes.com/quality/lead_free.htmlfor more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

Notes:

Date Code Key				т́× YM		YM = Da Y = Year	te Code M (ex: B = 2					
Year	201	4	2015		2016	20)17	2018		2019	2	2020
Code	В		С		D			F		G		Н
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteri	Symbol	Value	Unit		
Drain-Source Voltage	V _{DSS}	20	V		
Gate-Source Voltage	V _{GSS}	±12	V		
Continuous Drain Current (Note 6) $V_{GS} = 4.5V$	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	12.2 9.8	A
Continuous Drain Current (Note 6) V_{GS} = 2.5V	Steady State	T _A = +25°C T _A = +70°C	Ι _D	10.4 8.3	A
Pulsed Drain Current (10µs pulse, duty cycle = 19	I _{DM}	80	А		
Maximum Body Diode Continuous Current	ls	2.5	А		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	18	A		
Repetitive Avalanche Energy (Note 7) L = 0.1mH	E _{AS}	17	mJ		

Thermal Characteristics

Characteristic	Symbol	Мах	Unit
Power Dissipation (Note 6)	PD	2.1	W
Thermal Resistance, Junction to Ambient $@T_A = +25^{\circ}C$ (Note 6)	$R_{ ext{ heta}JA}$	59.1	°C/W
Thermal Resistance, Junction to Case (Note 6)	R ₀ JC	7.1	°C/W
Operating and Storage Temperature Range	TJ, TSTG	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	20	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current TJ = +25°C	I _{DSS}	_	_	1	μA	$V_{DS} = 16V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		—	±10	μA	$V_{GS} = \pm 10V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	0.3	_	1.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
				9.5		$V_{GS} = 4.5V, I_D = 10A$
			_	10		$V_{GS} = 4.0V, I_D = 10A$
Static Drain-Source On-Resistance	R _{DS(ON)}	_	_	10.5	mΩ	$V_{GS} = 3.5V, I_D = 9A$
				11.5		$V_{GS} = 3.1 V, I_D = 9 A$
			_	13		$V_{GS} = 2.5V, I_D = 8A$
Diode Forward Voltage	V _{SD}	_	_	1.2	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	Ciss	_	2,248	—	pF	
Output Capacitance	Coss		295	_	pF	− V _{DS} = 10V, V _{GS} = 0V, − f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}		265	_	pF	1 = 1.00012
Gate Resistance	Rg		1.5	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	24	_	nC	
Total Gate Charge (V _{GS} = 10V)	Qg	_	56	—	nC	
Gate-Source Charge	Q _{gs}	_	3.5	_	nC	$V_{DS} = 10V, I_D = 8.5A$
Gate-Drain Charge	Q _{gd}	_	5.1	_	nC	7
Turn-On Delay Time	t _{D(on)}	_	3.6	_	ns	
Turn-On Rise Time	tr	_	2.6	_	ns	V _{DS} = 10V, I _D = 8.5A
Turn-Off Delay Time	t _{D(off)}		21.6		ns	$V_{GS} = 4.5 V, R_G = 1.8 \Omega$
Turn-Off Fall Time	t _f		13.5	_	ns	7
Body Diode Reverse Recovery Time	t _{rr}		12.8	—	nS	I _F = 8.5A, dl/dt = 210A/µs
Body Diode Reverse Recovery Charge	Q _{rr}		6.9	_	nC	I _F = 8.5A, dl/dt = 210A/µs

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

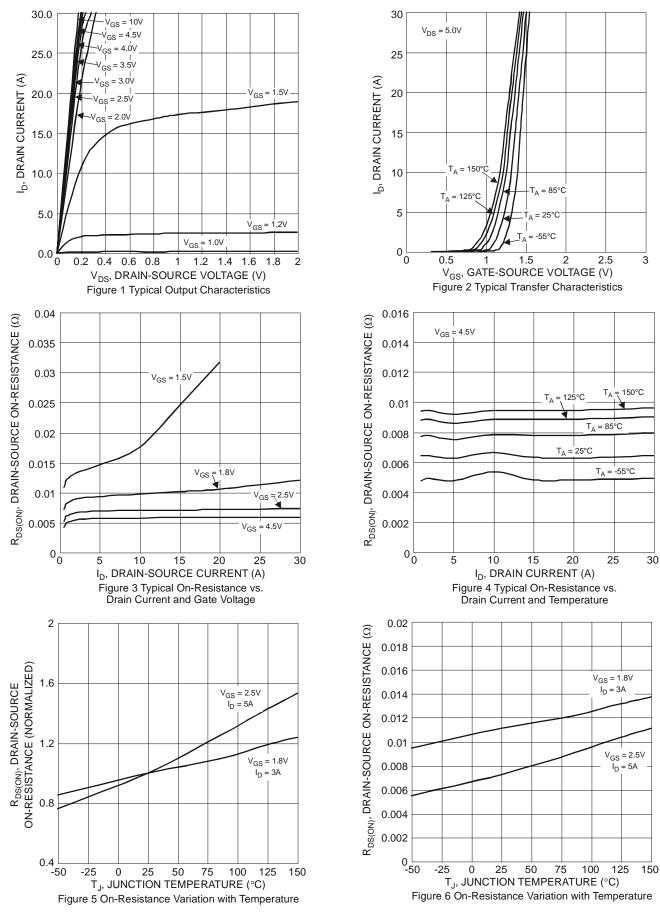
7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = +25°C.

8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.



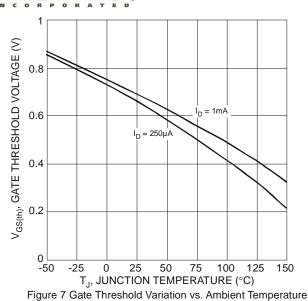
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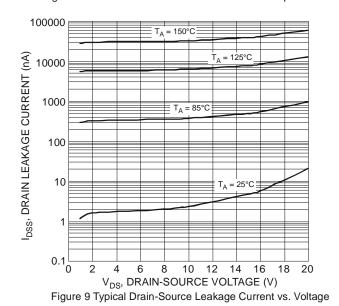


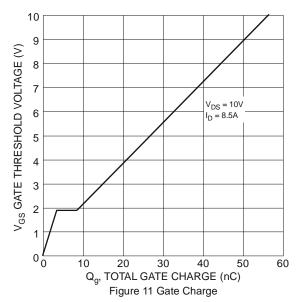
DMN2011UFX Document number: DS37250 Rev. 3 - 2

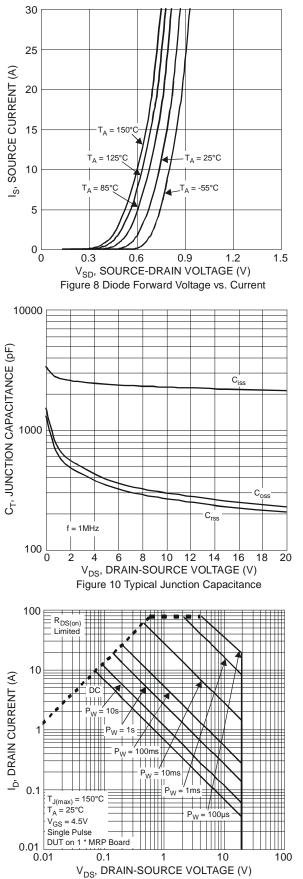


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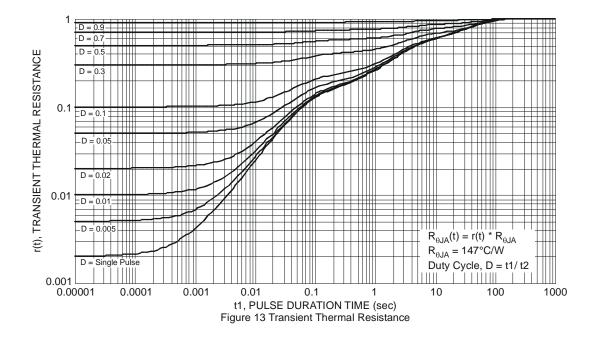








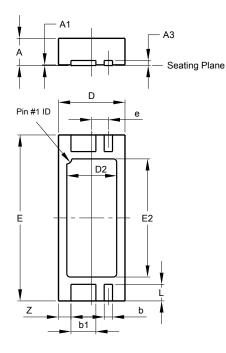






Package Outline Dimensions

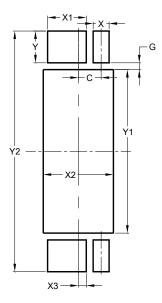
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



V-DFN2050-4							
Dim	Min	Max	Тур				
Α	0.75	0.85	0.80				
A1	0	0.05	0.02				
A3	-	-	0.15				
b	0.20	0.30	0.25				
b1	0.70	0.80	0.75				
D	1.90	2.10	2.00				
D2	1.40	1.60	1.50				
Е	4.90	5.10	5.00				
E2	3.46	3.66	3.56				
е	e 0.50 BSC						
L	0.35	0.65	0.50				
Z	-	-	0.375				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value			
Dimensions	(in mm)			
С	0.500			
G	0.150			
Х	0.350			
X1	0.850			
X2	1.540			
X3	0.175			
Y	0.700			
Y1	3.600			
Y2	5.300			



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